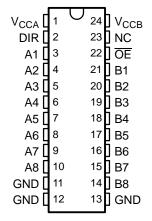
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FEATURES

- Bidirectional Voltage Translator
- 4.5 V to 5.5 V on A Port and 2.7 V to 5.5 V on B Port
- Control Inputs V_{IH}/V_{IL} Levels Are Referenced to V_{CCA} Voltage
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)

DB, DW, NS, OR PW PACKAGE (TOP VIEW)



NC - No internal connection

DESCRIPTION/ORDERING INFORMATION

This 8-bit (octal) noninverting bus transceiver uses two separate power-supply rails. The A port, V_{CCA} , is dedicated to accepting a 5-V supply level, and the configurable B port, which is designed to track V_{CCB} , accepts voltages from 3 V to 5 V. This allows for translation from a 3.3-V to a 5-V environment and vice versa.

The SN74LVCC4245A is designed for asynchronous communication between data buses. The device transmits data from the A bus to the B bus or from the B bus to the A bus, depending on the logic level at the direction-control (DIR) input. The output-enable (\overline{OE}) input can be used to disable the device so the buses effectively are isolated. The control circuitry (DIR, \overline{OE}) is powered by V_{CCA} .

ORDERING INFORMATION

T _A	PAC	KAGE ⁽¹⁾	ORDERABLE PART NUMBER	TOP-SIDE MARKING	
	SOIC - DW	Tube of 25	SN74LVCC4245ADW	LVCC4245A	
	SOIC - DW	Reel of 2000	SN74LVCC4245ADWR	LVCC4245A	
	SOP - NS	Reel of 2000	SN74LVCC4245ANSR	LVCC4245A	
–40°C to 85°C	SSOP - DB	Reel of 2000	SN74LVCC4245ADBR	LG245A	
		Tube of 60	SN74LVCC4245APW		
	TSSOP - PW	Reel of 2000	SN74LVCC4245APWR	LG245A	
		Reel of 250	SN74LVCC4245APWT		

⁽¹⁾ Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

FUNCTION TABLE (EACH TRANSCEIVER)

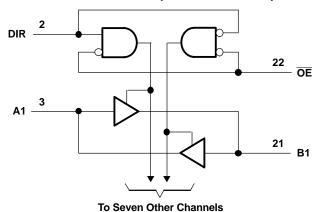
INP	UTS	OPERATION
ŌΕ	DIR	OPERATION
L	L	B data to A bus
L	Н	A data to B bus
Н	Χ	Isolation



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



LOGIC DIAGRAM (POSITIVE LOGIC)



Absolute Maximum Ratings(1)

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V_{CCA}	Supply voltage range		-0.5	6	V
		I/O ports (A port)	-0.5	V _{CCA} + 0.5	
VI	Input voltage range ⁽²⁾	I/O ports (B port)	-0.5	$V_{CCB} + 0.5$	V
		Except I/O ports	-0.5	$V_{CCA} + 0.5$	
Vo	Output valtage range (2)	A port	-0.5	V _{CCA} + 0.5	V
	Output voltage range ⁽²⁾	B port	-0.5	V _{CCB} + 0.5	V
I _{IK}	Input clamp current	V _I < 0		-50	mA
I _{OK}	Output clamp current	V _O < 0		-50	mA
Io	Continuous output current			±50	mA
	Continuous current through V _{CCA} , V _{CCB} , or C	GND		±100	mA
		DB package		63	
0	Dealers theread is a dealer (3)	DW package			
θ_{JA}	Package thermal impedance (3)	NS package		65	°C/W
		PW package		88	
T _{stg}	Storage temperature range	·	-65	150	°C

⁽¹⁾ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

⁽²⁾ This value is limited to 6 V maximum.

⁽³⁾ The package thermal impedance is calculated in accordance with JESD 51-7.



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Recommended Operating Conditions⁽¹⁾

		V _{CCA}	V _{CCB}	MIN	NOM	MAX	UNIT
V_{CCA}	Supply voltage			4.5	5	5.5	V
V_{CCB}	Supply voltage			2.7	3.3	5.5	V
		4.5 V	2.7 V	2			
V_{IHA}	High-level input voltage	4.5 V	3.6 V	2			V
		5.5 V	5.5 V	2			
		451/	2.7 V	2			
V_{IHB}	High-level input voltage	4.5 V	3.6 V	2			V
		5.5 V	5.5 V	3.85			
		4.5 V	2.7 V			0.8	
V_{ILA}	Low-level input voltage	4.5 V	3.6 V			0.8	V
		5.5 V	5.5 V			0.8	
		451/	2.7 V			0.8	
V_{ILB}	Low-level input voltage	4.5 V	3.6 V			0.8	V
		5.5 V	5.5 V			1.65	
		45.1/	2.7 V	2			
V_{IH}	High-level input voltage (control pins) (referenced to V _{CCA})	4.5 V	3.6 V	2			V
		5.5 V	5.5 V	2			
		45.	2.7 V			0.8	
V_{IL}	Low-level input voltage (control pins) (referenced to V_{CCA})	4.5 V	3.6 V			0.8	V
		5.5 V	5.5 V			0.8	
V _{IA}	Input voltage			0		V_{CCA}	V
V _{IB}	Input voltage			0		V_{CCB}	V
V _{OA}	Output voltage			0		V_{CCA}	V
V_{OB}	Output voltage			0		V_{CCB}	V
I _{OHA}	High-level output current	4.5 V	3 V			-24	mA
I _{OHB}	High-level output current	4.5 V	2.7 V to 4.5 V			-24	mA
I _{OLA}	Low-level output current	4.5 V	3 V			24	mA
I _{OLB}	Low-level output current	4.5 V	2.7 V to 4.5 V			24	mA
T _A	Operating free-air temperature			-40		85	°C

⁽¹⁾ All unused inputs of the device must be held at the associated V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

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Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PA	ARAMETER	TEST CONDITIONS	V _{CCA}	V _{CCB}	MIN	TYP	MAX	UNIT
V _{OHA}		$I_{OH} = -100 \mu A$	4.5 V	3 V	4.4	4.49		V
VOHA		$I_{OH} = -24 \text{ mA}$	4.5 V	3 V	3.76	4.25		V
		$I_{OH} = -100 \mu A$	4.5 V	3 V	2.9	2.99		
		I - 12 mA	4.5 V	2.7 V	2.2	2.5		
V		I _{OH} = -12 mA	4.5 V	3 V	2.46	2.85		V
V _{OHB}				2.7 V	2.1	2.3		V
		$I_{OH} = -24 \text{ mA}$	4.5 V	3 V	2.25	2.65		
				4.5 V	3.76	4.25		
V		I _{OL} = 100 μA	4.5 V	3 V			0.1	V
V _{OLA}		I _{OL} = 24 mA	4.5 V	3 V		0.21	0.44	V
		I _{OL} = 100 μA	4.5 V	3 V			0.1	
		I _{OL} = 12 mA	4.5 V	2.7 V		0.11	0.44	
V_{OLB}				2.7 V		0.22	0.5	V
		I _{OL} = 24 mA	4.5 V	3 V		0.21	0.44	
				4.5 V		0.18	0.44	
	Control inputs	V = V = or GND		3.6 V		±0.1	±1	
I _I	Control inputs	$V_I = V_{CCA}$ or GND	5.5 V	5.5 V		±0.1	±1	μΑ
$I_{OZ}^{(1)}$	A or B ports	$V_O = V_{CCA/B}$ or GND, $V_I = V_{IL}$ or V_{IH}	5.5 V	3.6 V		±0.5	±5	μΑ
		$A_n = V_{CC}$ or GND	5.5 V	Open		8	80	
I _{CCA}	B to A	I_O (A port) = 0, $B_n = V_{CCB}$ or GND	5.5 V	3.6 V		8	80	μΑ
		$B_n = V_{CCB}$ of GND	3.5 V	5.5 V		8	80	
	A to B	$A_n = V_{CCA}$ or GND, I_O (B port) = 0	5.5 V	3.6 V		5	50	μΑ
I _{CCB}	Alob	$A_n = V_{CCA}$ of GND, I_0 (B poin) = 0	3.5 V	5.5 V		8	80	μА
	A port	$\frac{V_{I}}{OE}$ = V _{CCA} - 2.1 V, Other inputs at V _{CCA} or GND, \overline{OE} at GND and DIR at V _{CCA}	5.5 V	5.5 V		1.35	1.5	
$\Delta I_{CCA}^{(2)}$	ŌĒ	$V_I = V_{CCA} - 2.1 \text{ V}$, Other inputs at V_{CCA} or GND, DIR at V_{CCA} or GND	5.5 V	5.5 V		1	1.5	mA
	DIR	$\frac{V_{I} = V_{CCA} - 2.1 \text{ V, Other inputs at } V_{CCA} \text{ or GND,}}{OE}$ at V_{CCA} or GND	5.5 V	3.6 V		1	1.5	
$\Delta I_{CCB}^{(2)}$	B port	$V_{\rm I}$ = $V_{\rm CCB}$ – 0.6 V, Other inputs at $V_{\rm CCB}$ or GND, $\overline{\rm OE}$ at GND and DIR at GND	5.5 V	3.6 V		0.35	0.5	mA
C _i	Control inputs	V _I = V _{CCA} or GND	Open	Open		5		pF
C _{io}	A or B ports	$V_O = V_{CCA/B}$ or GND	5 V	3.3 V		11		pF

 ⁽¹⁾ For I/O ports, the parameter I_{OZ} includes the input leakage current.
 (2) This is the increase in supply current for each input that is at one of the specified TTL voltage levels, rather than 0 V or the associated



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Switching Characteristics

over recommended operating free-air temperature range, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Figure 1 through Figure 4)

PARAMETER	FROM	TO (OUTPUT)	V_{CCA} = 5 V \pm 0.5 V, V_{CCB} = 5 V \pm 0.5 V		V_{CCA} = 5 V \pm 0.5 V, V_{CCB} = 2.7 V to 3.6 V		UNIT	
	(INPUT)	(001701)	MIN	MAX	MIN	MAX		
t _{PHL}	Α	В	1	7.1	1	7	nc	
t _{PLH}	A	Б	1	6	1	7	ns	
t _{PHL}	В	۸	1	6.8	1	6.2	20	
t _{PLH}	Б	A	1	6.1	1	5.3	ns	
t _{PZL}	ŌĒ	А	1	9	1	9	ns	
t _{PZH}	OE		1	8.3	1	8		
t _{PZL}	ŌĒ	D	1	8.2	1	10	no	
t _{PZH}	OE	В	1	8.1	1	10.2	ns	
t _{PLZ}	ŌĒ	A	1	4.7	1	5.2		
t _{PHZ}	OE	A	1	4.9	1	5.2	ns	
t _{PLZ}	ŌĒ	В	1	5.4	1	5.4	20	
t _{PHZ}	OE .	Б	1	6.3	1	7.4	ns	

Operating Characteristics

 $V_{CCA} = 5 \text{ V}, V_{CCB} = 3.3 \text{ V}, T_A = 25^{\circ}\text{C}$

	PARAMETER	TEST C	CONDITIONS	TYP	UNIT	
C _{pd} Power di	Dower dissination conseitance not transcriver	Outputs enabled	0	f = 10 MHz	20	٠
	Power dissipation capacitance per transceiver	Outputs disabled	$C_L = 0$,		6.5	p⊦

Power-Up Considerations(1)

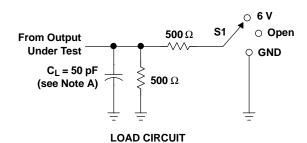
TI level-translation devices offer an opportunity for successful mixed-voltage signal design. A proper power-up sequence always should be followed to avoid excessive supply current, bus contention, oscillations, or other anomalies caused by improperly biased device pins. Take these precautions to guard against such power-up problems:

- 1. Connect ground before any supply voltage is applied.
- 2. Power up the control side of the device (V_{CCA} for all four of these devices).
- 3. Tie \overline{OE} to V_{CCA} with a pullup resistor so that it ramps with V_{CCA} .
- 4. Depending on the direction of the data path, DIR can be high or low. If DIR high is needed (A data to B bus), ramp it with V_{CCA} . Otherwise, keep DIR low.
- (1) Refer to the TI application report, Texas Instruments Voltage-Level-Translation Devices, literature number SCEA021.

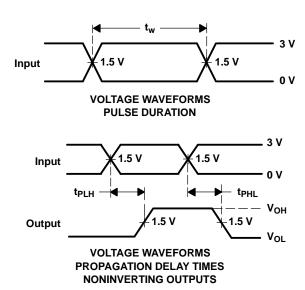


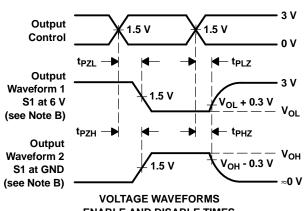


PARAMETER MEASUREMENT INFORMATION FOR A TO B $V_{\rm CCA}$ = 4.5 V TO 5.5 V AND $V_{\rm CCB}$ = 2.7 V TO 3.6 V



TEST	S 1
t _{PLH} /t _{PHL}	Open
t _{PLZ} /t _{PZL}	6 V
t _{PHZ} /t _{PZH}	GND





VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES
LOW- AND HIGH-LEVEL ENABLING

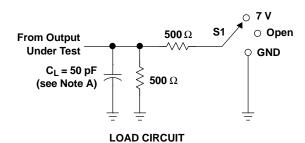
NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_{O} = 50 Ω , $t_{f} \leq$ 2.5 ns. $t_{f} \leq$ 2.5 ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. All parameters and waveforms are not applicable to all devices.

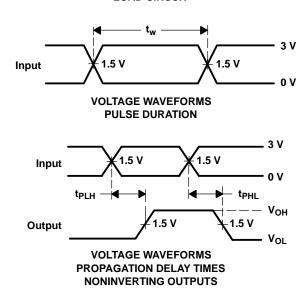
Figure 1. Load Circuit and Voltage Waveforms

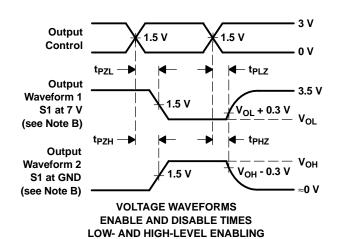
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PARAMETER MEASUREMENT INFORMATION FOR A TO B $V_{CCA} = 4.5 \text{ V TO } 5.5 \text{ V AND } V_{CCB} = 3.6 \text{ V TO } 5.5 \text{ V}$



TEST	S1
t _{PLH} /t _{PHL}	Open
t _{PLZ} /t _{PZL}	7 V
t _{PHZ} /t _{PZH}	GND





NOTES: A. C_L includes probe and jig capacitance.

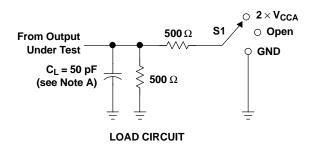
- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_0 = 50 Ω , $t_r \leq$ 2.5 ns, $t_f \leq$ 2.5 ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. All parameters and waveforms are not applicable to all devices.

Figure 2. Load Circuit and Voltage Waveforms

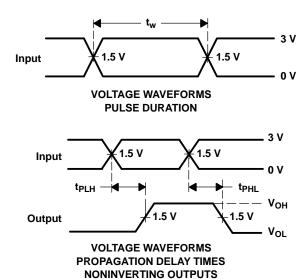


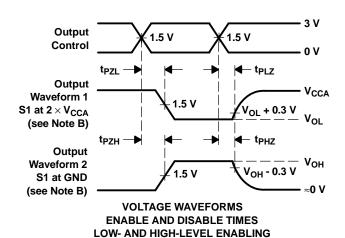


PARAMETER MEASUREMENT INFORMATION FOR B TO A V_{CCA} = 4.5 V to 5.5 V AND V_{CCB} = 2.7 V TO 3.6 V



TEST	S1
t _{PLH} /t _{PHL}	Open
t _{PLZ} /t _{PZL}	2×V _{CCA}
t _{PHZ} /t _{PZH}	GND





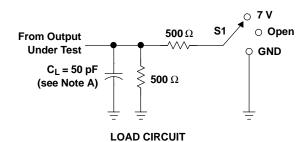
NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_Q = 50~\Omega$, $t_f \leq 2.5$ ns. $t_f \leq 2.5$ ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. All parameters and waveforms are not applicable to all devices.

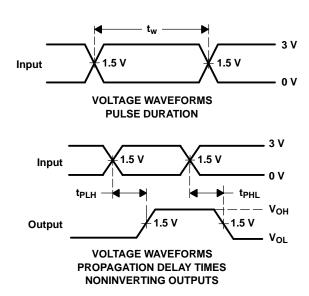
Figure 3. Load Circuit and Voltage Waveforms

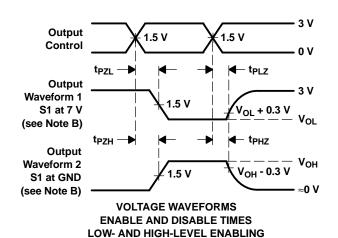
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PARAMETER MEASUREMENT INFORMATION FOR B TO A V_{CCA} = 4.5 V TO 5.5 V AND V_{CCB} = 3.6 V TO 5.5 V



TEST	S1
t _{PLH} /t _{PHL}	Open
t _{PLZ} /t _{PZL}	7 V
t _{PHZ} /t _{PZH}	GND





NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50~\Omega$, $t_f \leq$ 2.5 ns, $t_f \leq$ 2.5 ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. All parameters and waveforms are not applicable to all devices.

Figure 4. Load Circuit and Voltage Waveforms





24-Aug-2018

PACKAGING INFORMATION

Orderable Device	Status	Package Type	_	Pins	_	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
SN74LVCC4245ADBR	ACTIVE	SSOP	DB	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LG245A	Samples
SN74LVCC4245ADBRE4	ACTIVE	SSOP	DB	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LG245A	Samples
SN74LVCC4245ADW	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVCC4245A	Samples
SN74LVCC4245ADWE4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVCC4245A	Samples
SN74LVCC4245ADWR	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU CU SN	Level-1-260C-UNLIM	-40 to 85	LVCC4245A	Samples
SN74LVCC4245ADWRG4	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVCC4245A	Samples
SN74LVCC4245ANSR	ACTIVE	SO	NS	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVCC4245A	Samples
SN74LVCC4245APW	ACTIVE	TSSOP	PW	24	60	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LG245A	Samples
SN74LVCC4245APWR	ACTIVE	TSSOP	PW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LG245A	Samples
SN74LVCC4245APWRE4	ACTIVE	TSSOP	PW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LG245A	Samples
SN74LVCC4245APWRG4	ACTIVE	TSSOP	PW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LG245A	Samples
SN74LVCC4245APWT	ACTIVE	TSSOP	PW	24	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LG245A	Samples
SN74LVCC4245APWTE4	ACTIVE	TSSOP	PW	24	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LG245A	Samples

⁽¹⁾ The marketing status values are defined as follows: **ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.



PACKAGE OPTION ADDENDUM

24-Aug-2018

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF SN74LVCC4245A:

Enhanced Product: SN74LVCC4245A-EP

NOTE: Qualified Version Definitions:

• Enhanced Product - Supports Defense, Aerospace and Medical Applications

PACKAGE MATERIALS INFORMATION

www.ti.com 14-Feb-2019

TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LVCC4245ADBR	SSOP	DB	24	2000	330.0	16.4	8.2	8.8	2.5	12.0	16.0	Q1
SN74LVCC4245ADWR	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1
SN74LVCC4245ADWR	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1
SN74LVCC4245ADWRG4	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1
SN74LVCC4245ANSR	SO	NS	24	2000	330.0	24.4	8.3	15.4	2.6	12.0	24.0	Q1
SN74LVCC4245APWR	TSSOP	PW	24	2000	330.0	16.4	6.95	8.3	1.6	8.0	16.0	Q1
SN74LVCC4245APWT	TSSOP	PW	24	250	330.0	16.4	6.95	8.3	1.6	8.0	16.0	Q1

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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
SN74LVCC4245ADBR	SSOP	DB	24	2000	367.0	367.0	38.0	
SN74LVCC4245ADWR	SOIC	DW	24	2000	350.0	350.0	43.0	
SN74LVCC4245ADWR	SOIC	DW	24	2000	364.0	361.0	36.0	
SN74LVCC4245ADWRG4	SOIC	DW	24	2000	350.0	350.0	43.0	
SN74LVCC4245ANSR	SO	NS	24	2000	367.0	367.0	45.0	
SN74LVCC4245APWR	TSSOP	PW	24	2000	367.0	367.0	38.0	
SN74LVCC4245APWT	TSSOP	PW	24	250	367.0	367.0	38.0	



SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



MECHANICAL DATA

NS (R-PDSO-G**)

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013 variation AD.



DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Refer to IPC7351 for alternate board design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



DB (R-PDSO-G**)

PLASTIC SMALL-OUTLINE

28 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-150

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